

# Using X-ray measurements to assess uncertainties in plasma temperature and impurity profiles in tokamaks

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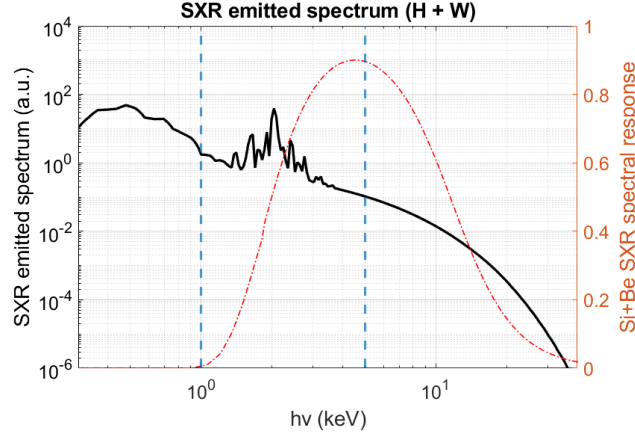
In tokamaks, the local X-ray plasma emissivity results from the contribution of several plasma parameters, i.e. electron temperature, density and concentration of impurities in multiple ionization states. In particular, the impurity core concentration can be estimated from the emissivity in the soft X-ray (SXR) range 0.1 – 20 keV, while information about suprathermal electrons is obtained in the hard X-ray (HXR) range 20 keV – 200 keV [1]. Estimating tungsten (W) concentration is subject to uncertainties as it requires accurate knowledge of plasma temperature, magnetic equilibrium, atomic processes leading to its cooling factor and diagnostic spectral response [2]. When other plasma parameters are known, the W impurity density can be reconstructed in the core with the help of SXR tomographic tools [3], using:

$$n_W = \frac{\varepsilon_{\text{SXR}}^\eta - \sum_{S \neq W} \varepsilon_S^\eta}{n_e \cdot L_W^\eta(T_e)}, \quad (1)$$

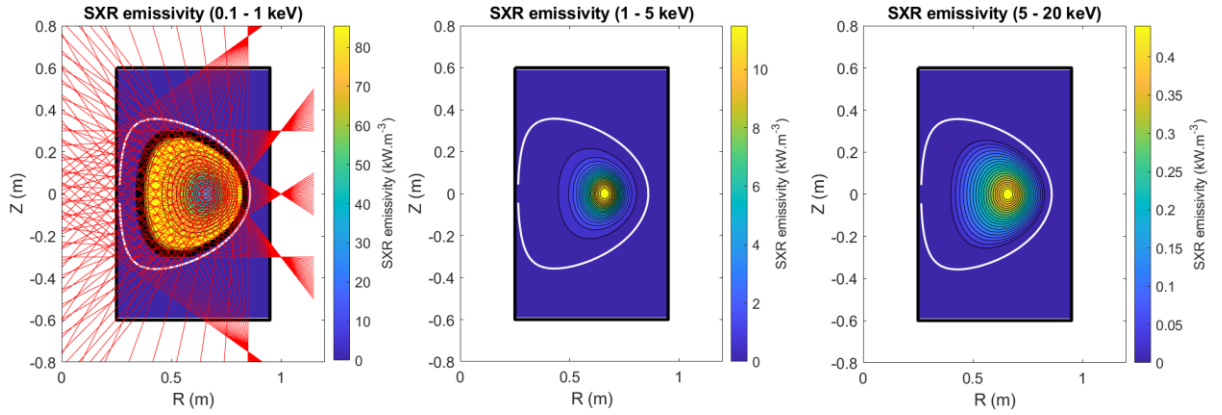
where  $\varepsilon_{\text{SXR}}^\eta$  denotes the reconstructed SXR emissivity,  $\sum_{S \neq W} \varepsilon_S^\eta$  the contribution from the background plasma and other impurities, and  $L_W^\eta$  the SXR-filtered W cooling factor, assuming a weak dependency to density and local W transport  $L_W^\eta(T_e, n_e, \vec{\Gamma}_W) \approx L_W^\eta(T_e)$ . Nevertheless, in the case of a significant suprathermal electron fraction e.g. due to RF heating, electron temperature estimation from ECE measurements can become a challenging task [4].

Therefore, the goal of this contribution is to establish a methodology to assess the uncertainty in the core  $T_e$  and  $c_W = n_W/n_e$  based on several X-ray measurements. The strategy is to define a grid of  $(T_{e,0}, c_{W,0})$  candidates, keeping the same radial shape, and identify the ones having the highest consistency with multiple line-integrated measurements in different energy bands. The method is at first tested on well-known synthetic profiles in an arbitrary tokamak geometry [3] to study the capabilities of the approach. W line emission is estimated thanks to the Photon Emissivity Coefficients (PEC) provided by Open-ADAS [5]. A synthetic line-integrated SXR spectrum emitted by a plasma containing W impurities ( $c_W = 10^{-4}$ ) is presented in Fig. 1, where three spectral regions are identified: 0 - 1 keV and 1 - 5 keV

dominated by line emission and a continuous part around 5 – 20 keV. A typical silicon diode + 50 $\mu$ m Be spectral response is shown as an example.



**Figure 1.** Simulated line-integrated emitted SXR spectrum from the plasma [3] with W impurities. The simulated 2D emissivity remapped onto a magnetic equilibrium, in the three defined spectral ranges, is depicted in Fig. 2. The range 0.1 – 1 keV carries more information about the plasma edge while the two ranges > 1 keV contain more information about the core.



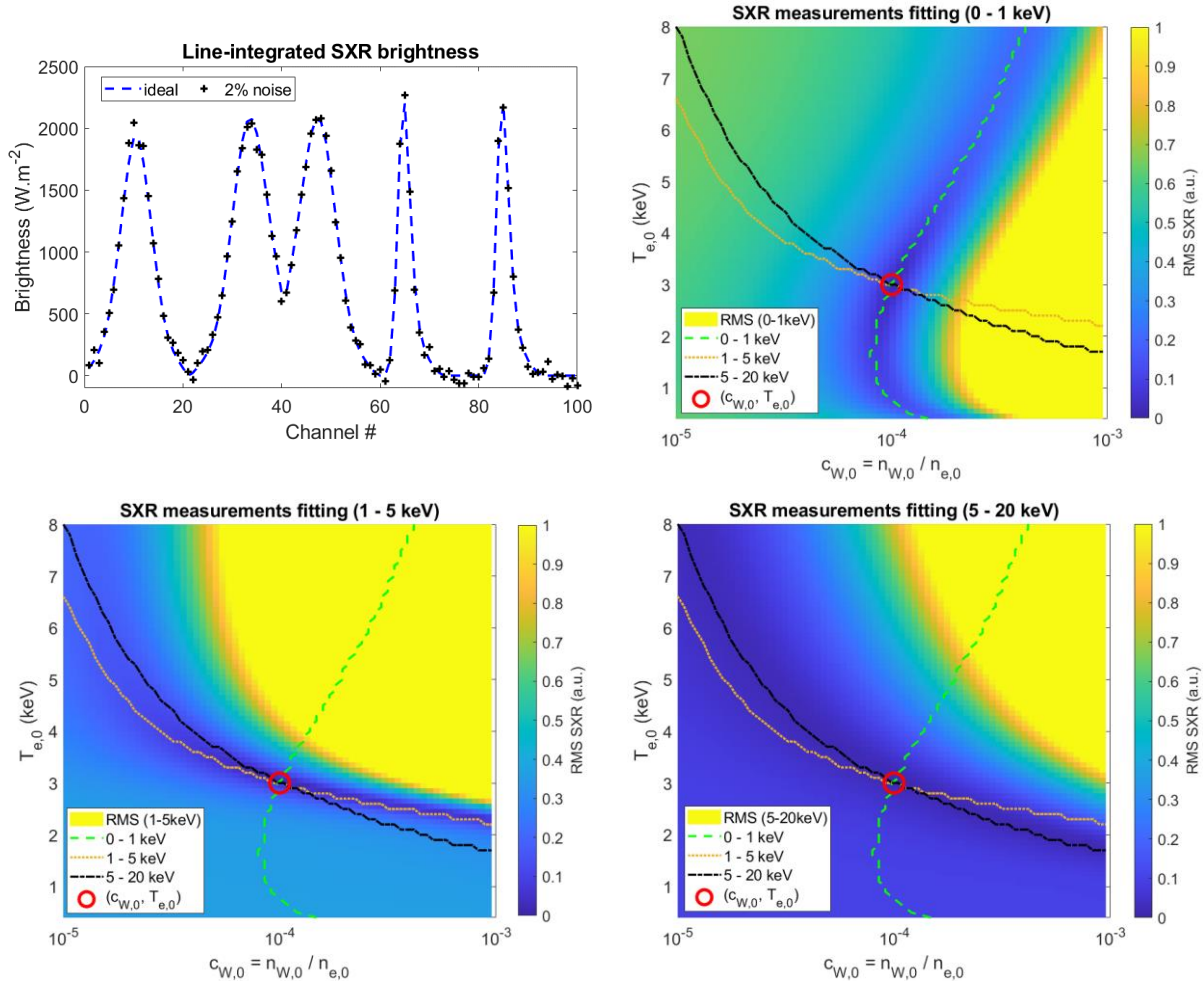
**Figure 2.** Synthetic plasma 2D emissivity integrated in the three defined spectral ranges. The measurements integrated over every line-of-sight (LoS) of the five defined cameras, in each of these three spectral ranges, can be obtained by definition of the forward problem:

$$f_i^\eta = \int_{LoS} \varepsilon^\eta(R, Z) dr_i + \tilde{f}_i^\eta, \quad (2)$$

where  $f_i^\eta$  is the measurement along the  $i$ -th LoS in the spectral range  $\eta$  and  $\tilde{f}_i^\eta$  is perturbative noise (2% Gaussian noise assumed here). The figure of merit  $RMS_{SXR}$  to minimize in order to find  $(T_{e,0}, c_{W,0})$  candidates compatible with  $N_f$  measurements is defined as:

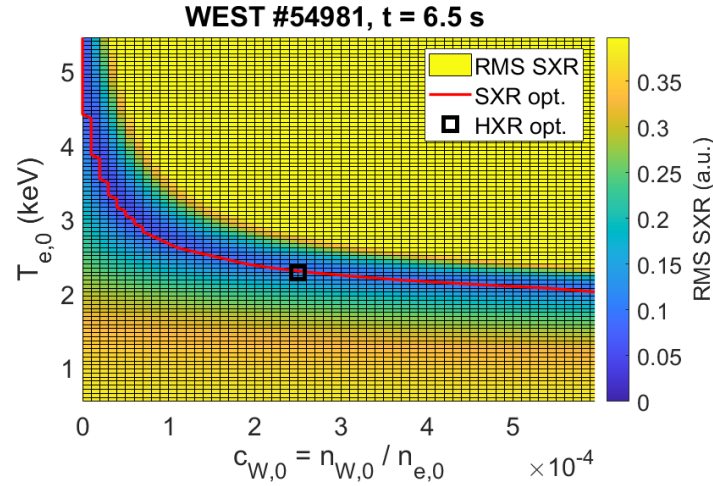
$$RMS_{SXR}(c_{W,0}, T_{e,0}) = \frac{1}{\max(f_{i,meas})} \sqrt{\frac{1}{N_f} \sum_{i=1}^{N_f} (f_i(c_{W,0}, T_{e,0}) - f_{i,meas})^2}, \quad (3)$$

where  $f_i(c_{W,0}, T_{e,0})$  are the measurements expected in the  $(c_{W,0}, T_{e,0})$  scenario, assuming that radial shapes are known, and  $f_{i,meas}$  are the measurements of reference. Such  $RMS_{SXR}$  map is established in our synthetic case and shown in Fig. 3. Visibly, each spectral range defines a curve  $T_{e,0} = f(c_{W,0})$  of compatible plasma parameters and the crossing of these curves in different energy ranges allow recovering the original scenario  $(c_{W,0}, T_{e,0}) = (10^{-4}, 3.0 \text{ keV})$ .



**Figure 3.** Synthetic SXR brightness in the range 1 - 5keV and RMS SXR error maps for the three spectral ranges 0 - 1 keV, 1 - 5 keV and 5 - 20 keV.

A first experimental test is presented for the WEST discharge #54981 @6.5s, see Fig. 4. The  $RMS_{SXR}$  map is performed thanks to the DTOMOX horizontal camera measurements. One can see that while a central temperature below 2 keV is unlikely regardless the  $c_{W,0}$  value, a temperature above 4 keV would require a very low amount of W impurities. The HXR measurements are used as a second diagnostic to cross-check SXR information, however since the use of the C3PO-LUKE-R5X2 chain of codes [6] makes it computationally challenging to establish a full  $(c_{W,0}, T_{e,0})$  map, only selected scenarios were considered as in [1] and the result of the optimisation is presented in Fig. 4 (black square).



**Figure 4.** SXR RMS error map for WEST #54981 @ $t = 6.5$  s and result of the HXR optimisation.

In summary, it has been shown that X-ray line integrated measurements can be used in different energy bands to estimate both  $c_{W,0}$  and  $T_{e,0}$  in tokamak plasmas. The methodology has been tested with synthetic profiles, and preliminary tests have been performed with experimental WEST data in the SXR and HXR range. A similar exercise has been recently performed with bolometry/SXR and combined with tomographic inversions to recover radial profiles [7]. This methodology opens promising perspectives for tomography diagnostics that exhibit energy resolution capabilities, such as Gas Electron Multiplier (GEM) detectors [8].

## References

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